

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/534,361	HAYASHI ET AL.	
Examiner	Art Unit	
*Charles I Boyer	1796	

SEARCHED				
Class	Subclass	Date	Examiner	
510	123	1/2/08	CB	
	127		1	
	235			
	237			
	271			
	290			
	333			
	351			
	426			
	427			
	432			
	506	V	W	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
510	123	1/2/08	CB	
	125	1	1	
	127			
	235			
	237			
	271			
	290		<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE.	EXMR			
West search	1/2/08	CB			
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